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October 2013

# FGB3236\_F085 / FGI3236\_F085 EcoSPARK

# **Device Maximum Ratings** $T_A = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Ratings	Units
BV <sub>CER</sub>	Collector to Emitter Breakdown Voltage (I <sub>C</sub> = 1mA)	360	V
BV <sub>ECS</sub>	Emitter to Collector Voltage - Reverse Battery Condition (I <sub>C</sub> = 10mA)	24	V
E <sub>SCIS25</sub>	Self Clamping Inductive Switching Energy ( $I_{SCIS} = 14.7A, L = 3.0 \text{mHy}, T_J = 25^{\circ}\text{C}$ )	320	mJ
E <sub>SCIS150</sub>	Self Clamping Inductive Switching Energy ( $I_{SCIS} = 10.4A$ , L = 3.0mHy, $T_{J} = 150$ °C)	160	mJ
I <sub>C25</sub>	Collector Current Continuous, at V <sub>GE</sub> = 4.0V, T <sub>C</sub> = 25°C	44	Α
I <sub>C110</sub>	Collector Current Continuous, at V <sub>GE</sub> = 4.0V, T <sub>C</sub> = 110°C	27	Α
$V_{GEM}$	Gate to Emitter Voltage Continuous	±10	V
D	Power Dissipation Total, at T <sub>C</sub> = 25°C	187	W
$P_D$	Power Dissipation Derating, for T <sub>C</sub> > 25°C	1.25	W/°C
T <sub>J</sub>	Operating Junction Temperature Range	-40 to +175	°C
T <sub>STG</sub>	Storage Junction Temperature Range	-40 to +175	°C
T <sub>L</sub>	Max. Lead Temp. for Soldering (Leads at 1.6mm from case for 10s)	300	°C
T <sub>PKG</sub>	Max. Lead Temp. for Soldering (Package Body for 10s)	260	°C
ESD	Electrostatic Discharge Voltage at 100 pF, 1500 $\Omega$	4	kV

# **Package Marking and Ordering Information**

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FGB3236	FGB3236_F085	TO263	330mm	24mm	800 units
FGI3236	FGI3236_F085	TO262	Tube	NA	50 units

# **Electrical Characteristics** $T_A = 25$ °C unless otherwise noted

Symbol Parameter T	est Conditions	Min	Тур	Max	Units
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#### **Off State Characteristics**

BV <sub>CER</sub>	Collector to Emitter Breakdown Voltage	$I_{CE} = 2mA, V_{GE} = 0,$ $R_{GE} = 1K\Omega, See Fig. 15$ $T_{J} = -40 \text{ to } 150^{\circ}\text{C}$		330	363	390	٧
BV <sub>CES</sub>	Collector to Emitter Breakdown Voltage	$I_{CE} = 10 \text{mA}, V_{GE} = 0 \text{V},$ $R_{GE} = 0,$ $T_{J} = -40 \text{ to } 150^{\circ}\text{C}$		350	378	410	٧
BV <sub>ECS</sub>	Emitter to Collector Breakdown Voltage	$I_{CE} = -75 \text{mA}, V_{GE} = 0 \text{V},$ $T_{C} = 25 ^{\circ}\text{C}$		30	-	1	V
$BV_{GES}$	Gate to Emitter Breakdown Voltage	$I_{GES} = \pm 2mA$		±12	±14	-	V
1		V <sub>CES</sub> = 250V,	$T_{\rm C} = 25^{\rm o}{\rm C}$	1	1	25	μΑ
ICES	Collector to Efficient Leakage Current	See Fig. 11	$T_{\rm C} = 150^{\rm o}{\rm C}$	-	-	1	mA
1	Emitter to Collector Leakage Current	V <sub>EC</sub> = 24V,	$T_{\rm C} = 25^{\rm o}{\rm C}$	-	-	1	mA
IECS	Emilier to Collector Leakage Current	See Fig.11	$T_{\rm C} = 150^{\rm o}{\rm C}$	-	-	40	MA
R <sub>1</sub>	Series Gate Resistance			-	100	-	Ω
R <sub>2</sub>	Gate to Emitter Resistance			10K	-	30K	Ω

### **On State Characteristics**

V <sub>CE(SAT)</sub>	Collector to Emitter Saturation Voltage	I <sub>CE</sub> = 6A, V <sub>GE</sub> = 4V,	T <sub>C</sub> =25°C, See Fig. 3	1	1.14	1.4	V
V <sub>CE(SAT)</sub>	Collector to Emitter Saturation Voltage	$H_{\alpha -} = 100  V_{\alpha -} = 4.5V$	$T_C = 150$ °C, See Fig. 4	1	1.32	1.7	٧
$V_{CE(SAT)}$	Collector to Emitter Saturation Voltage	$I_{CE} = 15A, V_{GE} = 4.5V,$	$T_{\rm C}$ = 150°C	-	1.61	2.05	V
I <sub>CE(ON)</sub>	Collector to Emitter On State Current	$V_{GE}$ = 5V, $V_{CE}$ = 5V		50	-	-	Α

# **Electrical Characteristics** $T_A = 25^{\circ}C$ unless otherwise noted

Parameter

Dynamic Characteristics							
Q <sub>G(ON)</sub>	Gate Charge	I <sub>CE</sub> = 10A, V <sub>CE</sub> = 12V, V <sub>GE</sub> = 5V, See Fig.14		-	20	-	nC
\/ ·	Gate to Emitter Threshold Voltage	I <sub>CE</sub> = 1mA, V <sub>CE</sub> = V <sub>GE</sub>	$T_{\rm C} = 25^{\rm o}{\rm C}$	1.3	1.6	2.2	V
$V_{GE(TH)}$	Gate to Enfitter Threshold Voltage	See Fig. 10	$T_{\rm C} = 150^{\rm o}{\rm C}$	0.75	1.1	1.8	V
$V_{GEP}$	Gate to Emitter Plateau Voltage	V <sub>CE</sub> = 12V, I <sub>CE</sub> = 10A		-	2.6	-	V

**Test Conditions** 

Min

Max Units

# **Switching Characteristics**

Symbol

t <sub>d(ON)R</sub>	Current Turn-On Delay Time-Resistive	02 . 2	-	0.65	4	μS
$t_{rR}$	Current Rise Time-Resistive	$V_{GE} = 5V, R_G = 1K\Omega$ $T_J = 25^{\circ}C, See Fig.12$	-	1.7	7	μS
t <sub>d(OFF)L</sub>	Current Turn-Off Delay Time-Inductive	$V_{CE} = 300V, L = 500 \mu Hy,$	-	5.4	15	μS
t <sub>fL</sub>	Current Fall Time-Inductive	$V_{GE} = 5V, R_G = 1K\Omega$ T <sub>J</sub> = 25°C, See Fig.12	-	1.64	15	μS
SCIS	Self Clamped inductive Switching	$T_J = 25^{\circ}\text{C}$ , L = 3.0mHy, $I_{CE} = 14.7\text{A}$ , $R_G = 1\text{K}\Omega$ , $V_{GE} = 5\text{V}$ , See Fig.1&2	-	1	320	mJ

# **Thermal Characteristics**

R <sub>0</sub> JC Thermal Resistance Junction to Case All Packages	0.8	°C/W
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# **Typical Performance Curves**

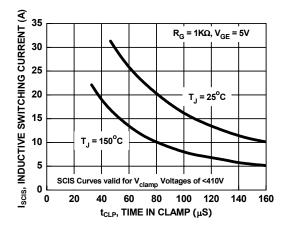
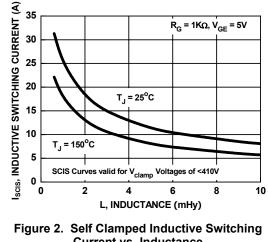


Figure 1. Self Clamped Inductive Switching Current vs. Time in Clamp



Current vs. Inductance

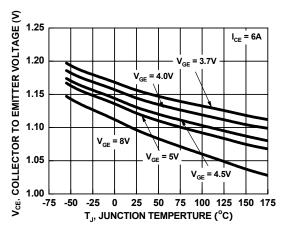


Figure 3. Collector to Emitter On-State Voltage vs. Junction Temperature

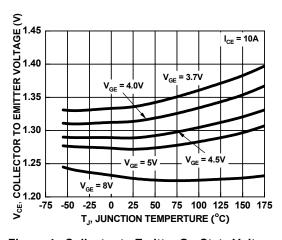


Figure 4. Collector to Emitter On-State Voltage vs. Junction Temperature

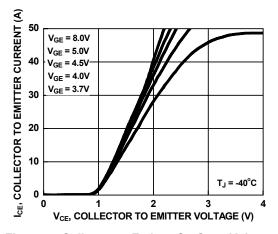


Figure 5. Collector to Emitter On-State Voltage vs. Collector Current

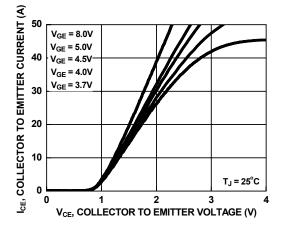


Figure 6. Collector to Emitter On-State Voltage vs. Collector Current

# Typical Performance Curves (Continued)

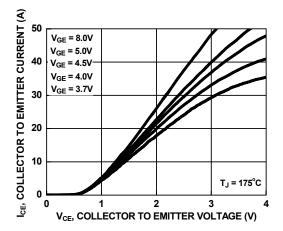


Figure 7. Collector to Emitter On-State Voltage vs. Collector Current

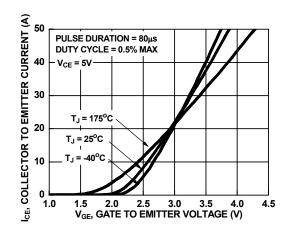


Figure 8. Transfer Characteristics

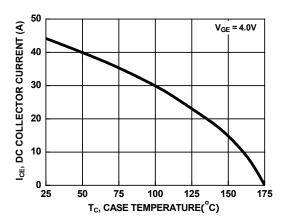


Figure 9. DC Collector Current vs. Case Temperature

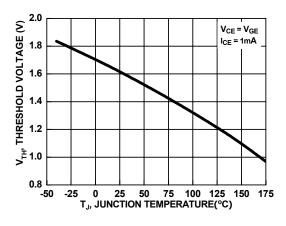


Figure 10. Threshold Voltage vs. Junction Temperature

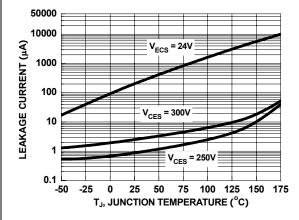


Figure 11. Leakage Current vs. Junction Temperature

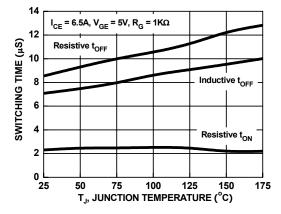


Figure 12. Switching Time vs. Junction Temperature

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**Typical Performance Curves** (Continued)

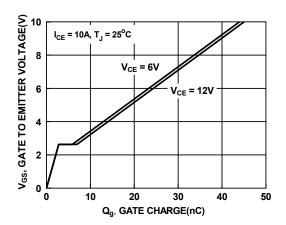


Figure 13. Capacitance vs. Collector to Emitter Voltage

Figure 14. Gate Charge

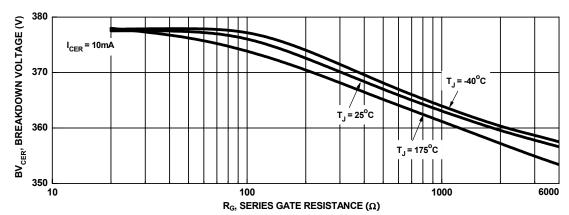


Figure 15. Break Down Voltage vs. Series Gate Resistance

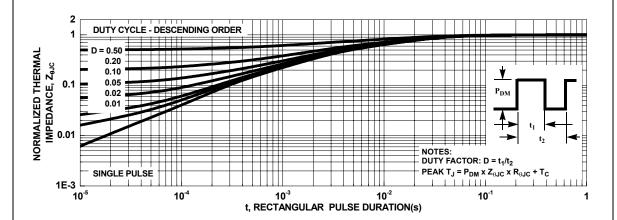


Figure 16. IGBT Normalized Transient Thermal Impedance, Junction to Case

# **Test Circuit and Waveforms**

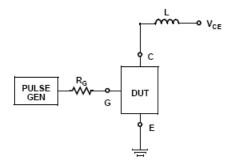


Figure 17. Inductive Switching Test Circuit

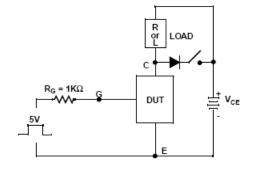


Figure 18.  $t_{ON}$  and  $t_{OFF}$  Switching Test Circuit

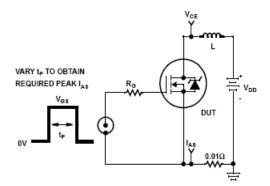


Figure 19. Energy Test Circuit

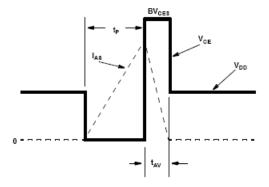
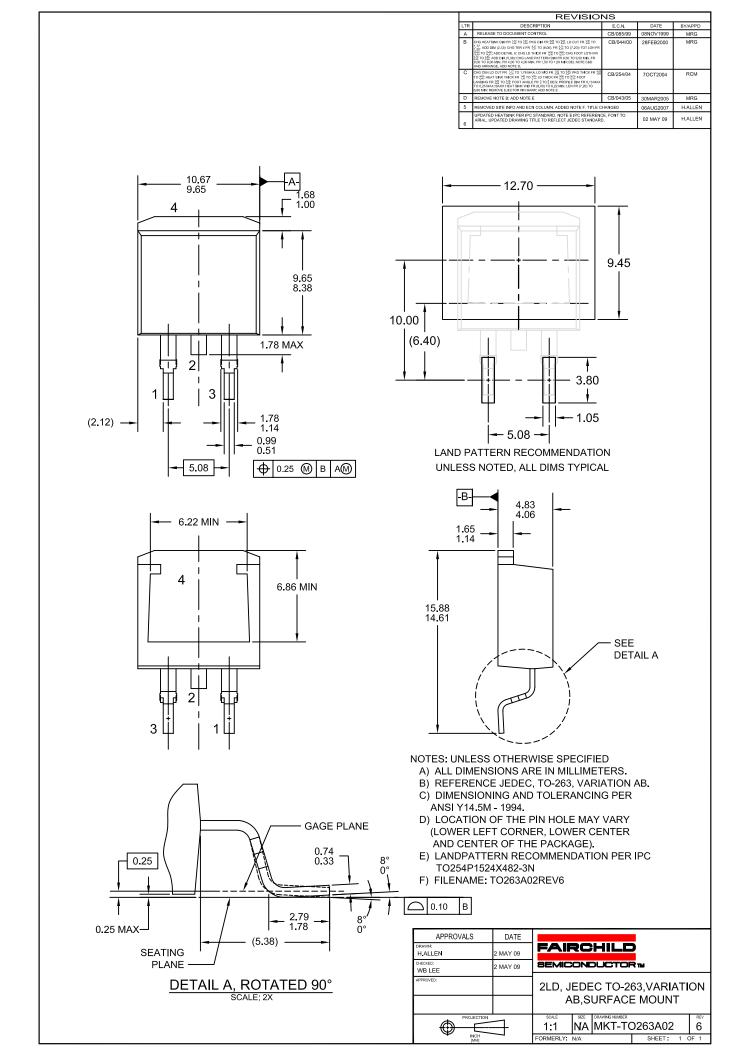
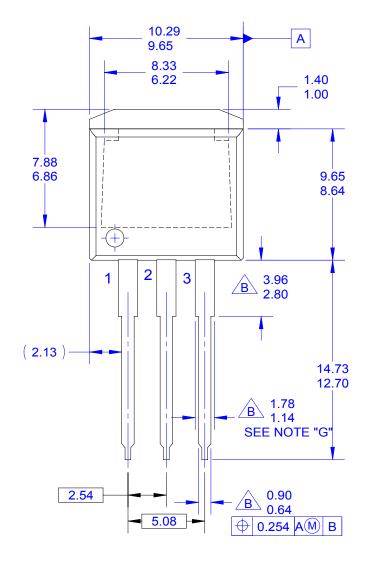
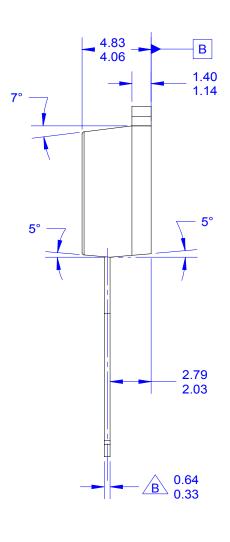


Figure 20. Energy Waveforms



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A. EXCEPT WHERE NOTED CONFORMS TO
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B DOES NOT COMPLY JEDEC STD. VALUE.
C. ALL DIMENSIONS ARE IN MILLIMETERS.
D. DIMENSIONS ARE EXCLUSIVE OF BURRS,
MOLD FLASH AND TIE BAR PROTRUSIONS.
E. DIMENSION AND TOLERANCE AS PER ANSI
V14 5-1904

F. LOCATION OF PIN HOLE MAY VARY
(LOWER LEFT CORNER, LOWER CENTER
AND CENTER OF PACKAGE)
G. MAXIMUM WIDTH FOR F102 DEVICE = 1.35 MAX.

H. DRAWING FILE NAME: TO262A03REV5

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Deminition of Terms		
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Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
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